

Notice of References Cited	Application/Control No. 10/707,801		Applicant(s)/Patent Under Reexamination YUAN ET AL.	
	Examiner Victor R. Kostak		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,293,244 A	03-1994	Kawaguchi, Yoshihiro	348/789
*	B	US-5,631,715	05-1997	Kirkpatrick et al.	348/839
*	C	US-5,860,720 A	01-1999	Negishi et al.	353/74
*	D	US-6,805,447 B2	10-2004	Takeuchi, Tadashi	353/71
*	E	US-2004/0263790 A1	12-2004	VanOverloop et al.	353/031
*	F	US-6,157,416 A	12-2000	Whitelaw et al.	348/789
*	G	US-4,177,484	12-1979	Boje, Daniel Q.	348/789
*	H	US-6,337,724 B1	01-2002	Itoh et al.	349/75
*	I	US-6,607,275 B1	08-2003	Cimini et al.	353/28
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.